Applicant(s)/Patent Under Application/Control No. Reexamination 10/001,295 MIRIYALA ET AL. Notice of References Cited Art Unit Examiner Page 1 of 1 Khai M Nguyen 2684 **U.S. PATENT DOCUMENTS** Document Number Date Name Classification Country Code-Number-Kind Code MM-YYYY 455/422 US-2002/0028674 03-2002 Slettengren et al. Α US-6,549,768 04-2003 Fraccaroli, Federico 455/456.3 В 05-1996 Bantz et al. 455/435.2 С US-5,519,706 US-Đ Ε US-US-F US-G US-Н USı US-J Κ US-L US-US-М FOREIGN PATENT DOCUMENTS Date **Document Number** Classification Name Country Country Code-Number-Kind Code MM-YYYY Ν 0 Ρ Q R S Т **NON-PATENT DOCUMENTS** Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages) W

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